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	SPECIFICATION	J
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SPEC. NO.: PS-318	363-XXXXX-001	REVISION: C
PRODUCT NAME:	0.5 mm PITCH USB TYPE C	CONN.
	18XX SERIES	
PRODUCT NO: 3		
PRODUCT NO: 3		
PRODUCT NO: 3	CHECKED:	APPROVED:
_	CHECKED: Chang, Chun Te	APPROVED: Kuo, Rong Hsun

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Revision History ECN # Rev. **Revision Description** Prepared Date 2020.10.28 Α ECN-000948 New product specification Hsu, Wei Chun 1. Modify Rated Voltage: DC 48V. 2. The mixed flowing gas is increased (Only for В ECN-004870 Hsu, Wei Chun 2021.11.03 30u" Au and 2u" Au + 30u" NiPd plating) Description. Modify : (A) Insulation Resistance (P5/P20). (B) Extraction force (P19). (C) Hot air reflow condition (P25). С ECN-012221 Hsu, Wei Chun 2023.05.03 Add : (A) Resistance to Reflow Soldering Heat (P9). (B) Salt Spray (Only For Gold Plating) (P9) (C) Group 8 (P11).

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2			s performance	, tests and q	uality requirements for).5mm pitch	USB Type C
	Aces' P/N	l: Receptacle: Plug : 318XX					
3	Universal	ABLE DOCU Serial Bus Type ELECTRONICS	e-C Cable and				
4	REQUIR	EMENTS					
	4.1 Design	and Construct	ion				
		luct shall be of luct drawing.	f design, cons	truction and	physical dimensions s	specified on	applicable
	4.2 Materia	als and Finish					
	4.2.1	Contact: High Finish: Refer	performance to the drawing		1		
	4.2.2	Housing: Ther	rmoplastic, Hig	h temp. UL	94 V-0		
	4.2.3	Shell: Stainles Finish: Refer	ss steel to the drawing	g.			
	4.2.4		id-Plate: Stain to the drawing				
	4.2.5	0	ch: Stainless s to the drawing				
	4.2.6	Plug EMC Sp Finish: Refer	•				
	4.3 Rating	S					
	4.3.1 4.3.2 4.3.3	A current of B9) and 1.2 through the	9 A shall be a 5 A shall be ap corresponding 25 A shall also	plied to the GND pins (be applied	tively to V _{BUS} pins (i.e., V _{CONN} pin (i.e., B5) as a i.e., pins A1, A12, B1, a individually to all the ot	pplicable, te nd B12). A r	rminated ninimum
	4.3.3	Operating ren	nperature : -40				

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5 Performance

5.1. ELECTRICAL REQUIREMENTS

	ELECTRICAL				
Item	Test Condition	Requirement			
Low Level Contact Resistance(LLCR)	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle. Measure at 20 mV (Max) open circuit at 100 mA.	40 mΩ (max) initial for all pin 50 mΩ (max) after initial measurement.			
Insulation Resistance	EIA 364-21. Mated and unmated connectors, apply 500 V DC between adjacent terminals. Applicable to both receptacle and plug.	A minimum of 100 M Ω insulation resistance			
Dielectric Withstanding Voltage	EIA-364-20 The dielectric shall withstand 100 VAC (RMS) for one minute at sea level after the environmental stress	No disruptive discharge Current leakage: 1 mA max.			
Contact Current Rating	Mate connector: measure the temperature rise at rated current after: A current of 9 A shall be applied collectively to V_{BUS} pins (i.e., pins A4, A9, B4, and B9) and 1.25 A shall be applied to the V_{CONN} pin (i.e., B5) as applicable, terminated through the corresponding GND pins (i.e., pins A1, A12, B1, and B12). A minimum current of 0.25 A shall also be applied individually to all the other contacts The ambient condition is still air at 25° C (EIA-364-70 METHOD 2)	When current is applied to the contacts, the temperature rise shall not exceed 30°C at the outside surface of the shell.			

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5.2 MECHANICAL REQUIREMENTS

ltem	Test Condition	Requirement
Insertion Force	EIA 364-13 Mate connector, At a maximum rate of 12.5 mm (0.492") per minute.	Within the range of 5 N to 20 N
Extraction Force	EIA 364-13 Un-mate connector, At a maximum rate of 12.5mm (0.492") per minute.	Initial: Within the range of 8 N to 20 N. After Test: Within the range of 6 N to 20 N
Durability	The durability rating shall be 10,000 cycles minimum for the USB Type-C connector family. The durability test shall be done at a rate of 500+/-50 cycles per hour and no physical damage to any part of the connector and cable assembly shall occur. (EIA-364-09)	No physical damage Contact resistance: 50 mΩ Max. After initial measurement Dielectric withstanding voltage: No disruptive discharge. Current leakage: 1 mA max. Insulation Resistance: 100 MΩ min. Extraction Force: Within the range of 6 N to 20 N
Durability (preconditioning)	Perform 50 unplug/plug cycles (EIA-364-09)	No physical damage
Vibration	EIA-364-28, test condition VII, test condition letter D,15 minutes in each of 3 mutually perpendicular directions. Both mating halves should be rigidly fixed so as not to contribute to the relative motion of one contact against another.	No evidence of physical damage No discontinuities of 1 μs or longer duration when mated connector during test. Contact resistance : 50 mΩ Max
4-Axis Continuity Test	 -The PCB shall be clamped on three sides of the receptacle no further than 5 mm away from the receptacle outline. - 5 mm ball tipped probe applied the force - Duration : 10 seconds - Direction: four directions (i.e., left, right, up, and down). 	No discontinuities greater than 1 microsecond duration in any of the four orientations tested.

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Wrenching Test	- Plug only - Direction: four directions (i.e., left, right, up, and down). - Duration: 10 seconds	The plug shall be mated with the continuity test fixture after the test forces have been applied to verify no damage has occurred that causes discontinuity or shorting. No plug damage: 0.75 Nm. No discontinuity or short after the test force applied. Dielectric withstanding voltage: No disruptive discharge for 100VAC(rms) The plug shall disengage from the test fixture or mechanically fail when a moment of 2.0 Nm is applied in the up and down directions and a moment 3.5 Nm is applied in the left and right directions.

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5.3 ENVIRONMENTAL REQUIREMENTS

	ENVIRONMENTAL				
Item	Test Condition	Requirement			
Temperature life	EIA-364-17, method A 105º C without applied voltage for 120 hours.	No evidence of physical damage Contact resistance: 50 mΩ Max.			
Temperature life (preconditioning)	EIA-364-17, method A 105º C without applied voltage for 72 hours.	No evidence of physical damage Contact resistance: 50 mΩ Max.			
Thermal shock	EIA-364-32, test condition I 10 cycles with the exception of exposure times. Place a thermocouple in the center of the largest mass component of the connector that is in the center of the test chamber to insure that the contacts reach the temperature extremes before ramping to the other temperature.	No evidence of physical damage Contact resistance: 50 mΩ Max.			
Mixed flowing gas (Only for 30u" Au and 2u" Au + 30u" NiPd plating)	EIA-364-65, class II Condition A Mate connectors, and subject to the mixed flowing gas conditions. 1)expose 1/2 of the specimens unmated for 2/3 of the test duration 2)mate each specimen to the same plug that it was mated to during temperature life (preconditioning); and, 3) expose for the remainder of the test duration. Duration: 7 day	No evidence of physical damage Contact resistance: 50 mΩ Max.			
Thermal disturbance	Cycle the connector or socket between 15 °C \pm 3 °C and 85 °C \pm 3 °C, as measured on the part. Ramps should be a minimum of 2 °C per minute, and dwell times should insure that the contacts reach the temperature extremes (a minimum of 5 minutes). Humidity is not controlled. Perform 10 such cycles.	Contact resistance: 50 mΩ Max.			

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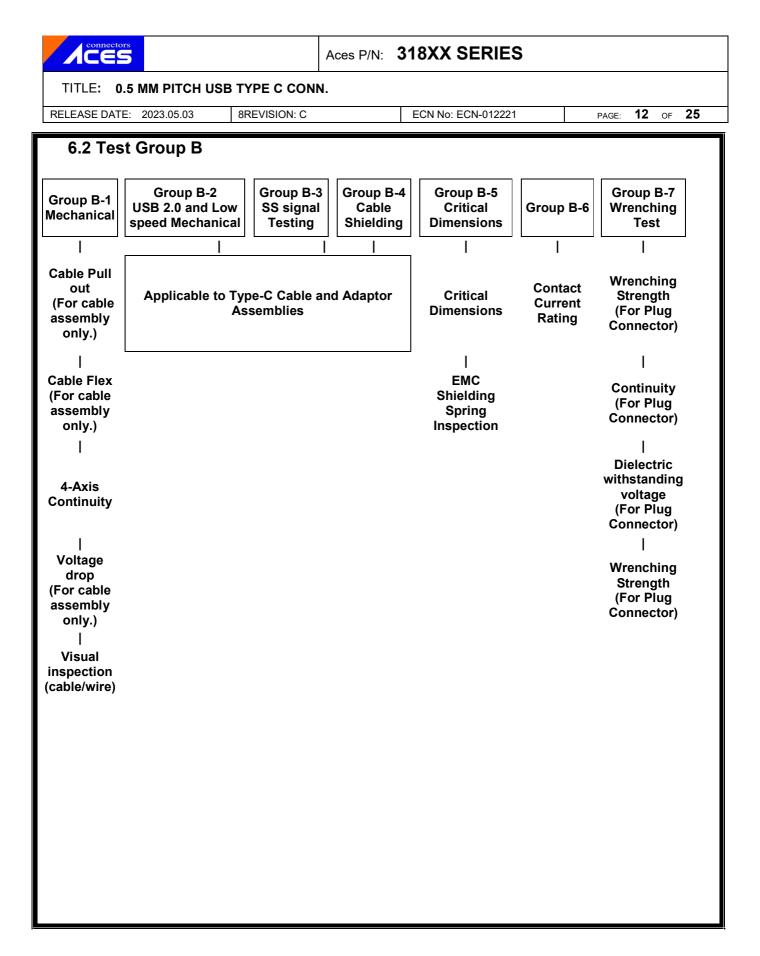
Cyclic temperature and humidity	EIA-364-31 Cycle the connector between 25 °C \pm 3 °C at 80 % \pm 3% RH and 65 °C \pm 3 °C at 50 % \pm 3% RH. Ramp times should be 0.5 hour and dwell times should be 1.0 hour. Dwell times start when the temperature and humidity have stabilized within the specified levels. Perform 24 such cycles.	No mechanical damage. Contact resistance: 50 mΩ Max. Insulation resistance: 100 MΩ min. Dielectric withstanding voltage: No disruptive discharge. Current leakage: 1 mA max.
Reseating	Manually unplug/plug the connector. Perform 3 such cycles.	No physical damage
Salt Spray (Only For Gold Plating)	See Test Group A_EIA 364-1000.1 and Group A-8	Subject mated/unmated connectors to 5% salt-solution concentration, 35°C. (I) Gold flash for 8 hours. (II) Gold plating over 5 u" for 48 Hours. (EIA-364-26)
Resistance to Reflow Soldering Heat	Resistance to Reflow Soldering Heat	Pre Heat: 150°C ~200°C , 60 ~120 sec. Heat: 217°C Min. , 100 sec. Min. 255°C Min. , 30 sec. Min. Peak Temp.: 260°C Max. Reflow number cycle: 2 time

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6 PRIMARY QUALIFICATION APPROVAL TESTING

Tool Crown	Title	Number o	f Specimens	
Test Group	Title	Receptacle Plug		
Test Group A	Reliability test EIA 364-1000.01 (A-1/A-2 / A-3 / A-4 / A-7)	30pcs 30pcs		
Test Group B-1	Mechanical test (B-1-4:4-Axis Continuity)	B-1-4 only ,8 pcs	B-1-4 only ,8 pcs	
Test Group B-5	B-5-1 : Critical Dimensions B-5-2 : EMC Shielding Spring Inspection			
Test Group B-6	Connector Pair Current Rating	3	3	
Test Group B-7	Plug connector Wrenching test	N/A	B-7-1 ,3 pcs B-7-4 ,12 pcs	

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6.1 Test Gi	roup A_EIA 364	-1000.1			
Group 1 5 sample	Group 2 5 sample	Group 3 5 sample	Group 4 5 sample	Group 7 5 sample	Group 8 5 sample
l Examination	ا Examination	l Examination	ا Examination	ا Dielectric withstanding	ا Examination
I	I	I	I	voltage 	I
LLCR Durability (50cyc)	LLCR Durability (50cyc)	LLCR Durability (50cyc)	LLCR Durability (50cyc)	LLCR Insertion Force	Salt spray Examination
Temperature life (120hr)	 Thermal Shock	 Temp Life (72hr)	 Temp Life (72hr)	 Extraction Force	
 LLCR	 LLCR	LLCR	LLCR	 Durability	
I	 Cyclic	I	I	I	
Reseating(3cyc)	temperature and Humidity	Vibration	Mixed flowing gas	Extraction Force	
I	I	I	I	I	
LLCR	LLCR	LLCR	LLCR	Durability (10k) I	
	Reseating(3cyc)		Thermal Disturbance	Extraction Force	
	LLCR		LLCR		
			Reseating(3cyc)	Dielectric withstanding voltage	
			 LLCR	 Insulation Resistance	
EIA test grou	ıps A-5 and A-6	o do not app∣	ly to this conne	ector	



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ltem	Test	Test procedure	Test criteria
1	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle. Measure at 20 mV (Max) open circuit at 100 mA. LLCR measurement of pin "A1" Voltmeter terminal PWR supply terminal PWR supply terminal	40 milliohms max for all contacts. Baseline measurement.
2	Durability (preconditioning)	EIA-364-09 Perform 50 unplug/plug cycles.	No evidence of physical damage
3	Temperature life	EIA-364-17, method A 105° C without applied voltage for 120 hours.	None
4	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.
5	Reseating	Manually unplug/plug the connector or socket. Perform 3 such cycles.	No evidence of physical damage
6	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.

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Test Group A-2 (required for all connectors)

tem	Test		T	est proc	edure	Test criteria
1	Low level contact resistance	recepta	easurement acle mated o l paddle car	40 milliohms max for al contacts. Baseline measurement		
2	Durability (preconditioning)	EIA-36 Perforn	4-09 n 50 unplug	No evidence of physica damage		
3	Thermal shock	10 cycl Place a mass c center reach t	a thermocou component c of the test c	exception ple in the of the conn hamber to ture extren ure.	of exposure times. center of the largest ector that is in the insure that the contacts nes before ramping to	None
4	Low level contact resistance	recepta	easurement acle mated o I paddle car	50 milliohms max.		

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5	Cyclic temperature and humidity	EIA-364-31 Cycle the connector between 25 °C ±3 °C at 80 % ±3% RH and 65 °C ±3 °C at 50 % ±3% RH. Ramp times should be 0.5 hour and dwell times should be 1.0 hour. Dwell times start when the temperature and humidity have stabilized within the specified levels. Perform 24 such cycles. Temperature 10 H $10 H$	None
6	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.
7	Reseating	Manually unplug/plug the connector or socket. Perform 3 such cycles.	No evidence of physical damage
8	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.

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Test Group A-3 (required for all connectors)

lte m	Test	Test procedure	Test criteria
1	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	40 milliohms max for all contacts. Baseline measurement.
2	Durability (preconditioning)	EIA-364-09 Perform 50 unplug/plug cycles.	No evidence of physica damage
3	Temperature life (preconditioning)	EIA-364-17, method A 105º C without applied voltage for 72 hours when used as preconditioning.	None
4	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.
5	Vibration	EIA-364-28, test condition VII, test condition letter D 15 minutes in each of 3 mutually perpendicular directions. Both mating halves should be rigidly fixed so as not to contribute to the relative motion of one contact against another.	No evidence of physica damage. No discontinuities of 1 µs or longer duration when mated connector during test.
6	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.

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Test Group A-4 (required for all connectors)

ltem	Test	Test procedure	Test criteria
1	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	40 milliohms max for all contacts. Baseline measurement.
2	Durability (preconditioning)	EIA-364-09 Perform 50 unplug/plug cycles.	No evidence of physical damage
3	Temperature life (preconditioning)	EIA-364-17, method A 105º C without applied voltage for 72 hours when used as preconditioning.	None
4	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.
5	Mixed flowing gas (Only for 30u" Au and 2u" Au + 30u" NiPd plating)	EIA-364-65, class II Condition A -Mate state (5pcs) Mate -Unmate state (5pcs) 112Hr 168Hr Unmate Mate Relative Rollutant Environmental Humidity Temperature Concentration, ppb Class % °C Cl ₂ NO ₂ H ₂ S SO ₂ II 70±2 30±1 10±3 200±50 10±5 100±20	None
6	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.

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7	Thermal disturbance	Cycle the connector or socket between 15 °C \pm 3 °C and 85 °C \pm 3 °C, as measured on the part. Ramps should be a minimum of 2 °C per minute, and dwell times should insure that the contacts reach the temperature extremes (a minimum of 5 minutes). Humidity is not controlled. Perform 10 such cycles. Temperature	None
		15°C 5min 35min 5min min. 35min As one cycle, total 10 cycles	
8	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.
9	Reseating	Manually unplug/plug the connector or socket. Perform 3 such cycles.	No evidence of physical damage
10	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.

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Test Group A-7 (EIA test groups A-5 and A-6 do not apply to this connector)

ltem	Test	Test procedure	Test criteria
1	Dielectric withstanding voltageEIA-364-20, 100 VAC (RMS) Perform 4 plug/unplug cycles.		No disruptive discharge Current leakage: 1 mA max.
2	Low level contact resistance	I recentacia mated contacts and does not include any	
3	3 Durability (preconditioning) EIA-364-09 Perform 4 unplug/plug cycles, followed by an unplug.		No evidence of physica damage.
4	Insertion force	EIA 364-13 At a maximum rate of 12.5 mm (0.492") per minute. (Total:5 cycles)	Within the range of 5 N to 20 N.
5	Extraction forceEIA 364-13 At a maximum rate of 12.5mm (0.492") per minut (Total:6 cycles)		Within the range of 8 N to 20 N.
6	DurabilityEIA 364-9 Perform 25 plug/unplug cycles. Cycle rate of 500 ± 50 cycles per hour followed by a plug. (Total:31 cycles)		No evidence of physica damage
7	7Extraction forceEIA 364-13 At a maximum rate of 12.5mm (0.492") per minute (Total:32 cycles)		Within : - 33% of the initial reading. - 8 N to 20 N.
8	Durability	EIA 364-9 Perform 2,468 plug/unplug cycles. (Total:2500 cycles) Rotate the receptacle or plug 180° and perform 2,500 plug/unplug cycles. Cycle rate of 500 +/-50 cycles per hour (total of 10,000 plug/unplug cycles, flipping every 2,500 cycles).	No evidence of physica damage
9	Extraction force	EIA 364-13 At a maximum rate of 12.5mm (0.492") per minute	Within 6 N to 20 N.

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10	Low level contact resistance	EIA-364-23 The measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle.	50 milliohms max.
11	Dielectric withstanding voltage	EIA-364-20, 100 VAC (RMS)	No disruptive discharge. Current leakage: 1 mA max.
12	Insulation Resistance	EIA 364-21. Mated and unmated connectors, apply 500 V DC between adjacent terminals. Applicable to both receptacle and plug.	A minimum of 100 MΩ insulation resistance is required between adjacent contacts of unmated and mated connectors

Test Group B-1: Type-C Connector and Cable Assembly Mechanical Tests

ltem	Test		Test procedure)	Test criteria
B-1-4	4-Axis Continuity	 -The PCB shall be clamped on three sides of the receptacle no further than 5 mm away from the receptacle outline. -5 mm ball tipped probe applied the force - Duration : 10 seconds - Direction: four directions (i.e., left, right, up, and down). 			
		Receptacle configuration with respect to mounting surface	Force and Moment Re Force at 15 mm from receptacle shell mating edge (N)	Moment with respect to receptacle shell mating edge (Nm)	
		Right angle	20	0.30	
		Vertical	8	0.12	

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Test Group B-5: Critical Dimensions

ltem	Test	Test procedure	Test criteria
B-5-1	Critical Dimensions	See customer drawing	N/A
B-5-2	EMC Shielding Spring Inspection	Visual inspection for compliance with Figure.	No EMC shielding spring finger tip of the USB Full-Featured Type-C plug or USB 2.0 Type-C plug shall be exposed in the plug housing opening of the unmated Type-C plug.

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Test Group B-6: Connector Pair Current Rating

ltem	Test	Test procedure	Test criteria
B-6	Contact Current Rating	Mate connector: measure the temperature rise at rated current after: A current of 9 A shall be applied collectively to V _{BUS} pins (i.e., pins A4, A9, B4, and B9) and 1.25 A shall be applied to the V _{CONN} pin (i.e., B5) as applicable, terminated through the corresponding GND pins (i.e., pins A1, A12, B1, and B12). A minimum current of 0.25 A shall also be applied individually to all the other contacts The ambient condition is still air at 25° C (EIA-364-70 METHOD 2) Measurement Point Receptacle shell top	When current is applied to the contacts, the temperature rise shall not exceed 30°C at the outside surface of the shell. This requirement applies to the USB Type-C connector mated pair only.

	Current R	ating Test PCB	
Item	Trace width (mm)	Trace length (mm) on each PCB	Thickness
Signal trace	0.25 max.	13 max.	70 µm (2 oz. copper)
Ground trace	1.57 max.	38 max.	70 µm (2 oz. copper)
V _{BUS} and V _{CONN}	1.25 max.	30 max.	70 µm (2 oz. copper)
РСВ	N/A	N/A	0.80 - 1.20 mm

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st Gro	oup B-7: Plug	Connector Wrenching Test	
ltem	Test	Test procedure	Test criteria
B-7-1	Wrenching Test	 Plug only Direction: four directions (i.e., left, right, up, and down). Duration: 10 seconds Wrenching Strength Test Fixture	The plug shall be mated with the continuity test fixture after the test forces have been applied to verify no damage has occurred
B-7-2	Continuity	Receptocle Mating DatumA B C C C DETAL B	that causes discontinuity or shorting. No plug damage: 0.75 Nm. No discontinuity or short after the test force applied.
B7-3	Dielectric withstanding voltage	Mated, 100 VAC (RMS)	No disruptive discharge. Current leakage: 1 mA max.

